


Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10711213	YANG ET AL.
	Examiner	Art Unit
	Sim, Yong	2635

SEARCHED			
Class	Subclass	Date	Examiner
345	173	12/07/2006	Yong Sim
349	12	12/07/2006	Yong Sim

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted SPE Vu Le to clarify the claim language. Electrode layers disclosed in the prior art is construed as a detetion circuit.	12/08/2006	Yong Sim
Conducted double patenting search on EAST and eDAN	12/08/2006	Yong Sim
Obtained Colgan2 for the rejection of claim 6 through an updated search.	5/17/2007	Yong Sim
Conducted updated search on EAST	10/10/2007	Yong Sim
Consulted SPE Amr Awad on using Boyd to make a 103 rejection	10/11/2007	Yong Sim
Consulted SPE Amr Awad on maintaining the rejection to make final.	4/7/2008	Yong Sim
Conducted an updated search	8/29/2008	Yong Sim
Consulted SPE Amr Awad on using Furuhashi reference	8/29/2008	Yong Sim
Consulted an associate examiner regarding the claim language interpretation	2/20/2009	Yong Sim

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--